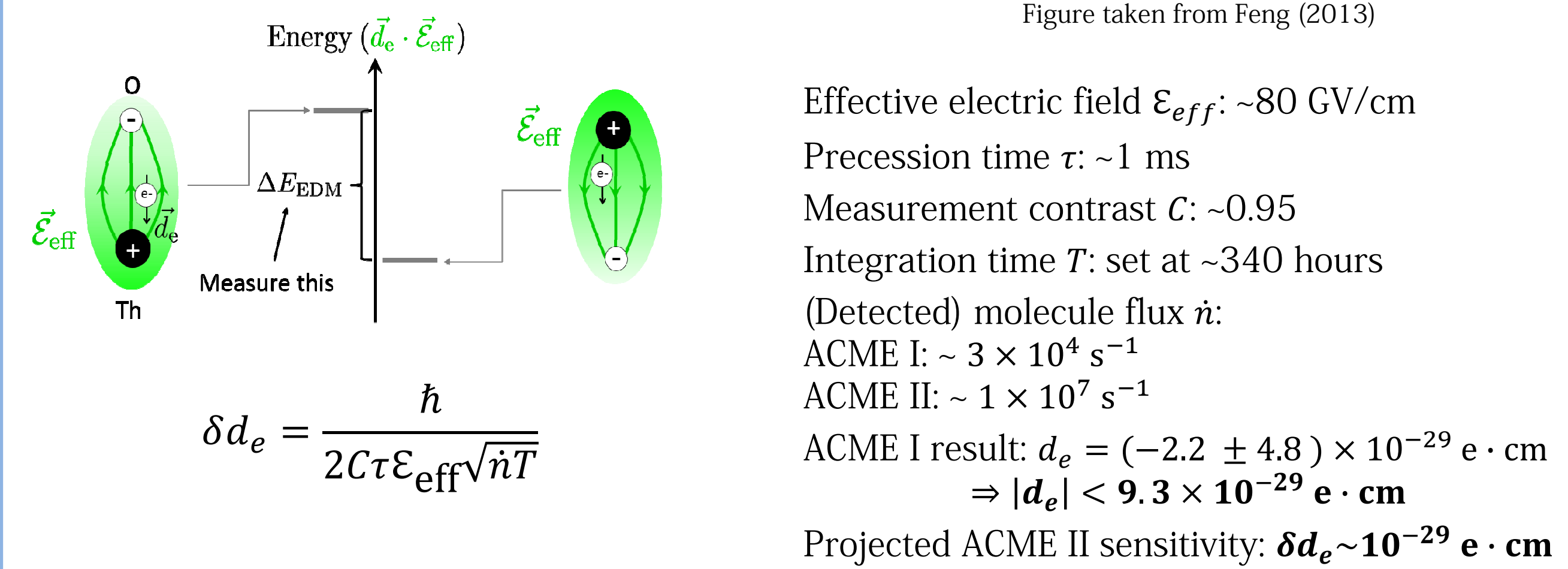
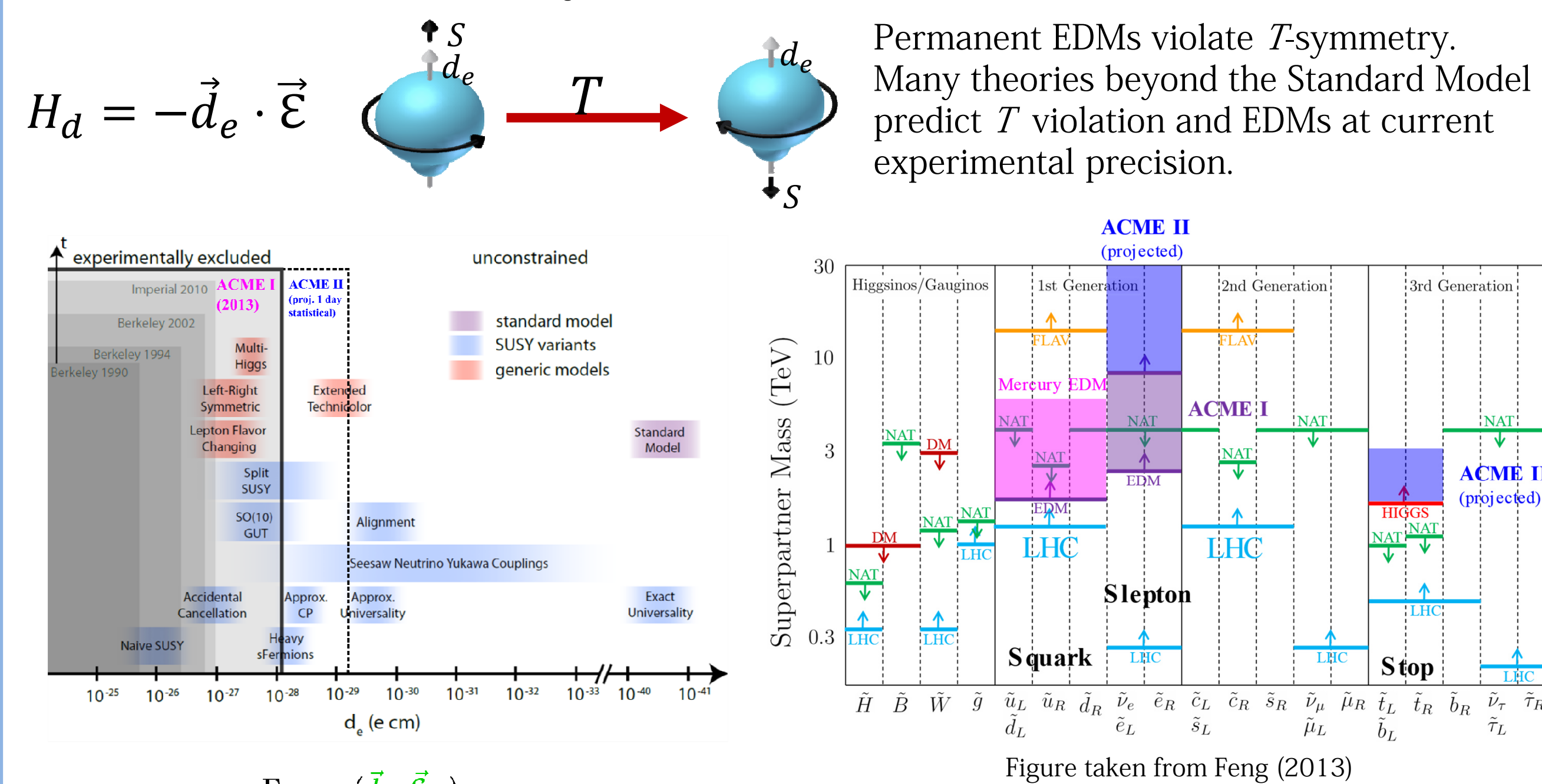


Progress Towards an Order of Magnitude Improvement on the Measurement of the Electron Electric Dipole Moment

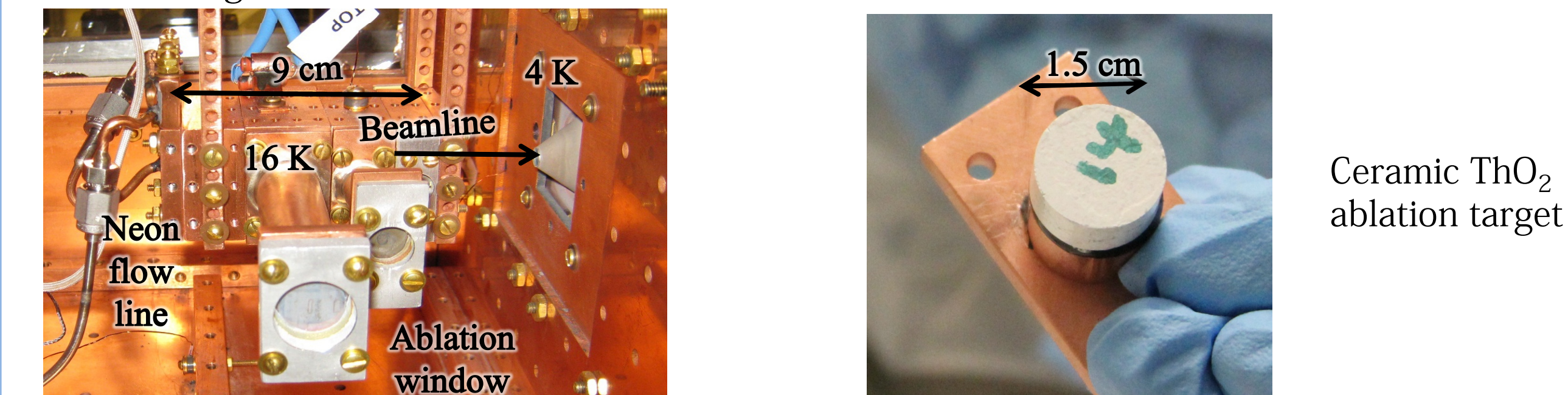
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Motivation & Theory



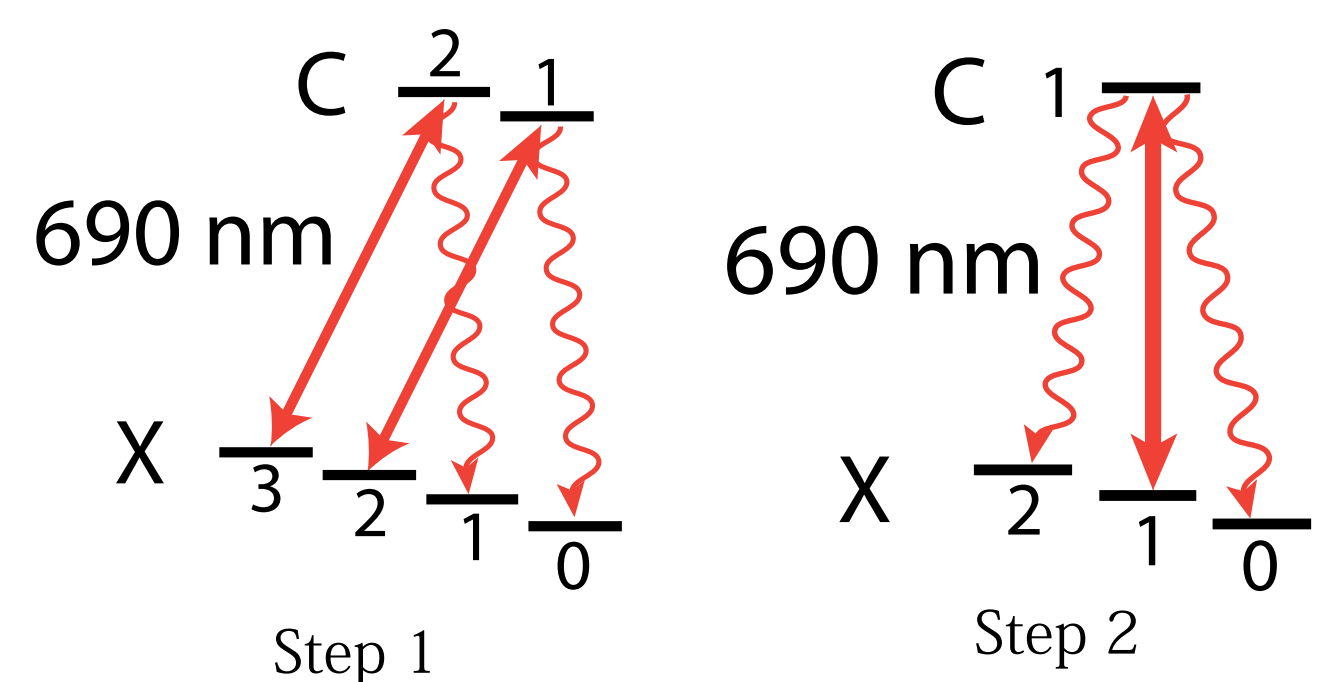
1. Buffer gas beam source

ThO in the gas phase is produced through pulsed ablation of a ceramic ThO₂ target with an Nd:YAG laser. Ablation is performed at 50 Hz in a cryogenic buffer gas cell. The ThO molecules thermalize with and are entrained in the flow of the neon buffer gas. The molecular beam is cooled to 4 K. Each pulse produces a flux of $\sim 10^{11}$ molecules per steradian in the electro-vibrational ground state.



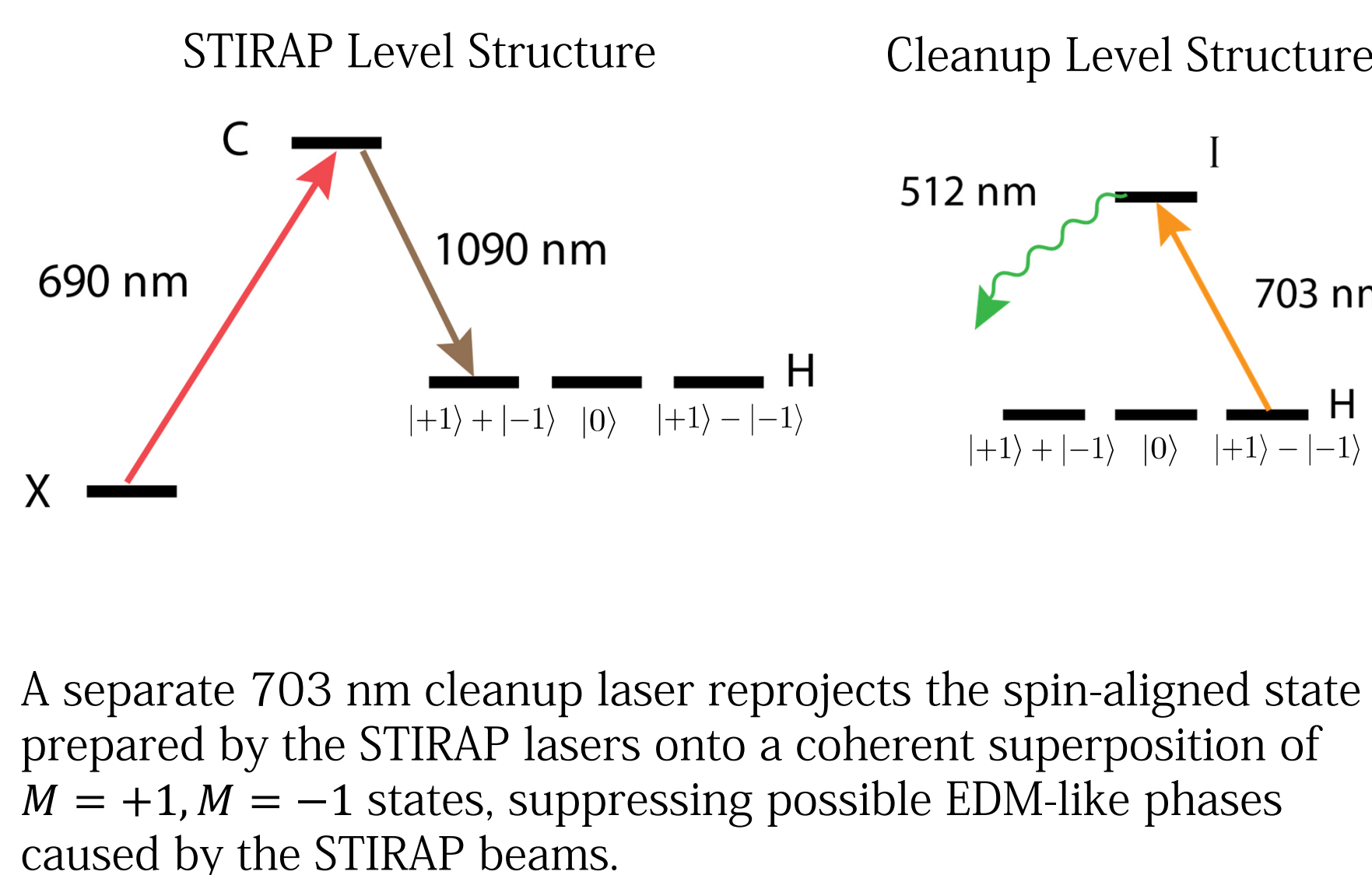
2. Rotational Cooling

The molecules in the X state are primarily distributed in the lowest four rotational states after leaving the cell. Optical pumping on the $X - C$ transition transfers population from the $J = 0, 1, 2$ levels to the $J = 0$ level, increasing usable molecule flux by a factor of ~ 2.7 .

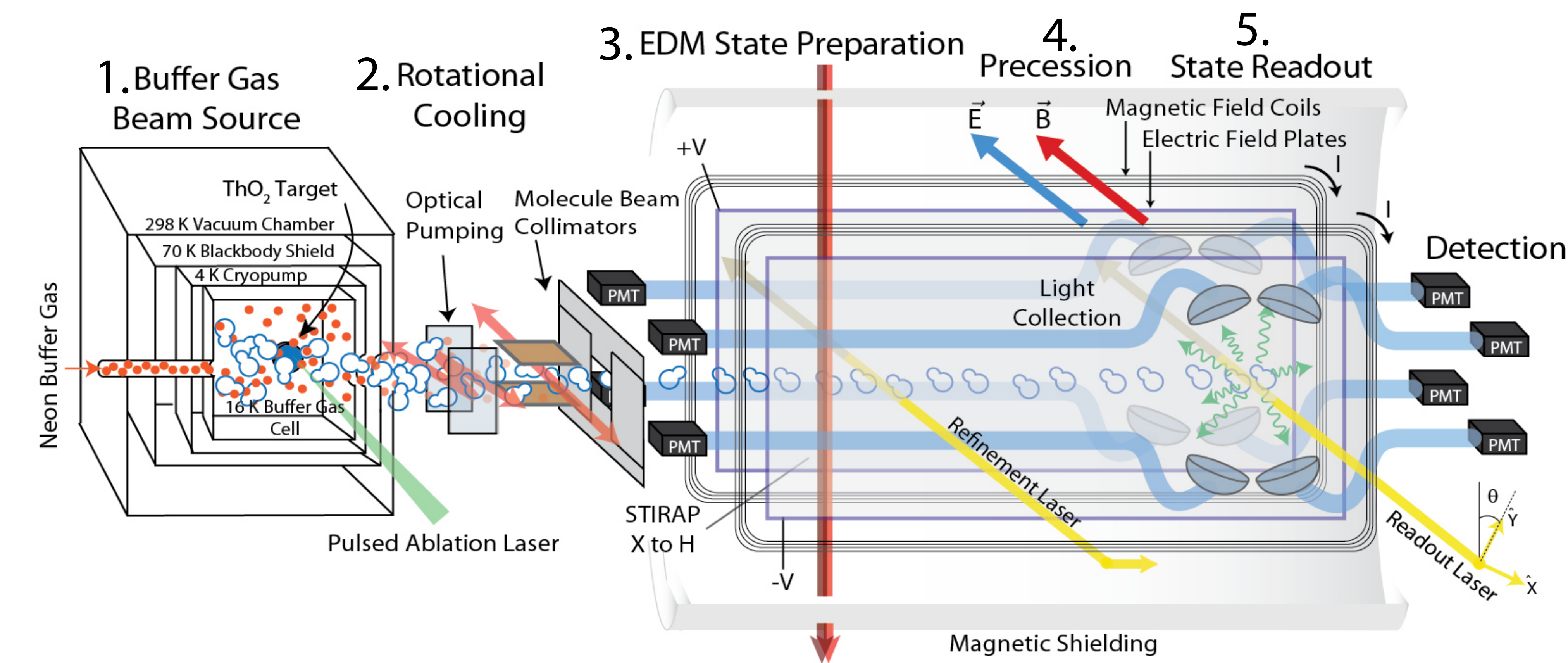
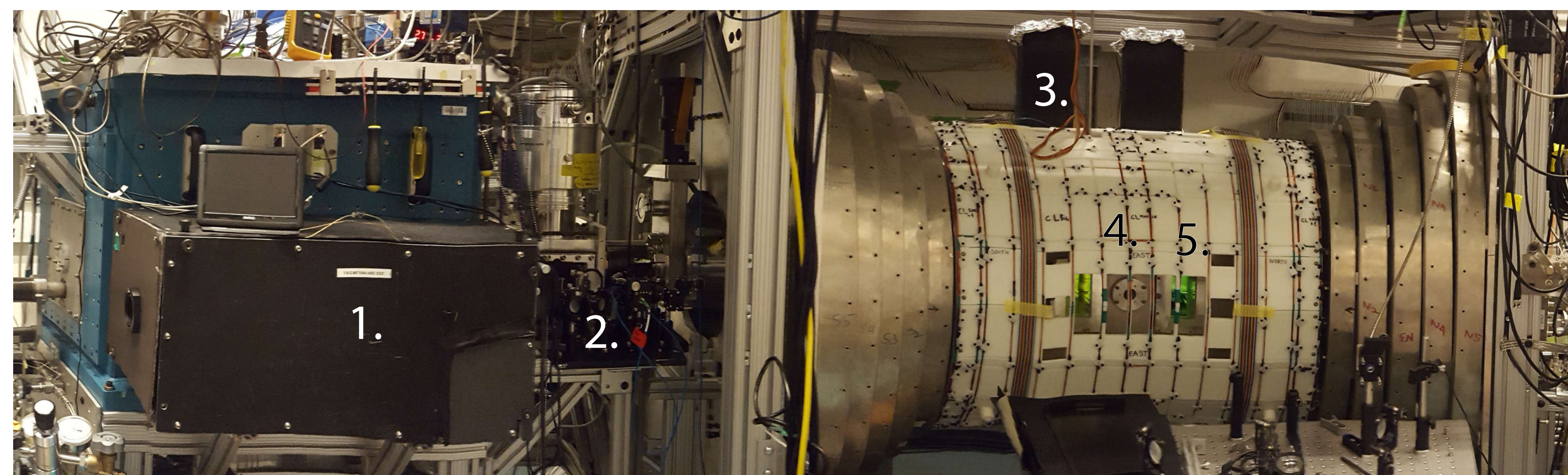


3. State Preparation

The EDM measurement is performed in the metastable H state. STIRAP coherently transfers population through an intermediate short-lived state to the spin-aligned state that represents the beginning of the EDM measurement. This transfer occurs with an efficiency of $\sim 75\%$.



ACME II Apparatus



4. State Precession

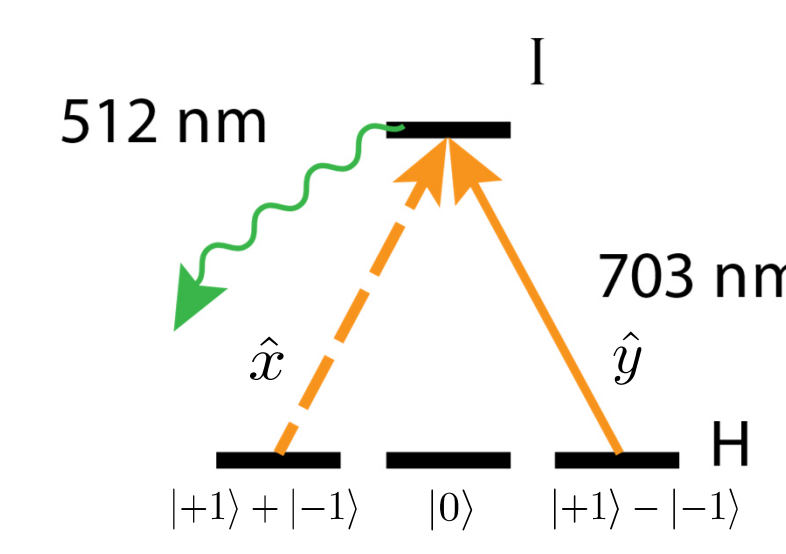
The molecules in the prepared state precess and acquire phase as they fly through the electric and magnetic fields of the interaction region.

$$\frac{1}{\sqrt{2}}(|-1\rangle + |+1\rangle) \rightarrow \frac{1}{\sqrt{2}}(e^{i\phi}|-1\rangle + e^{-i\phi}|+1\rangle)$$

$$\frac{\phi}{\tau} = -(\vec{B}g_1\mu_B B_z + \vec{N}\vec{E}d_e\mathcal{E}_{eff})$$

5. State Readout

At the end of the interaction region, the final state is projected to a pair of orthogonal basis vectors by subjecting the molecules to a 703 nm probe laser (on the H-I transition) with linear polarization rapidly switched (200 kHz) between x and y.



We collect the 512 nm fluorescence using PMTs as the molecules in the short-lived I-state decay back to the ground state.

Data Acquisition Structure

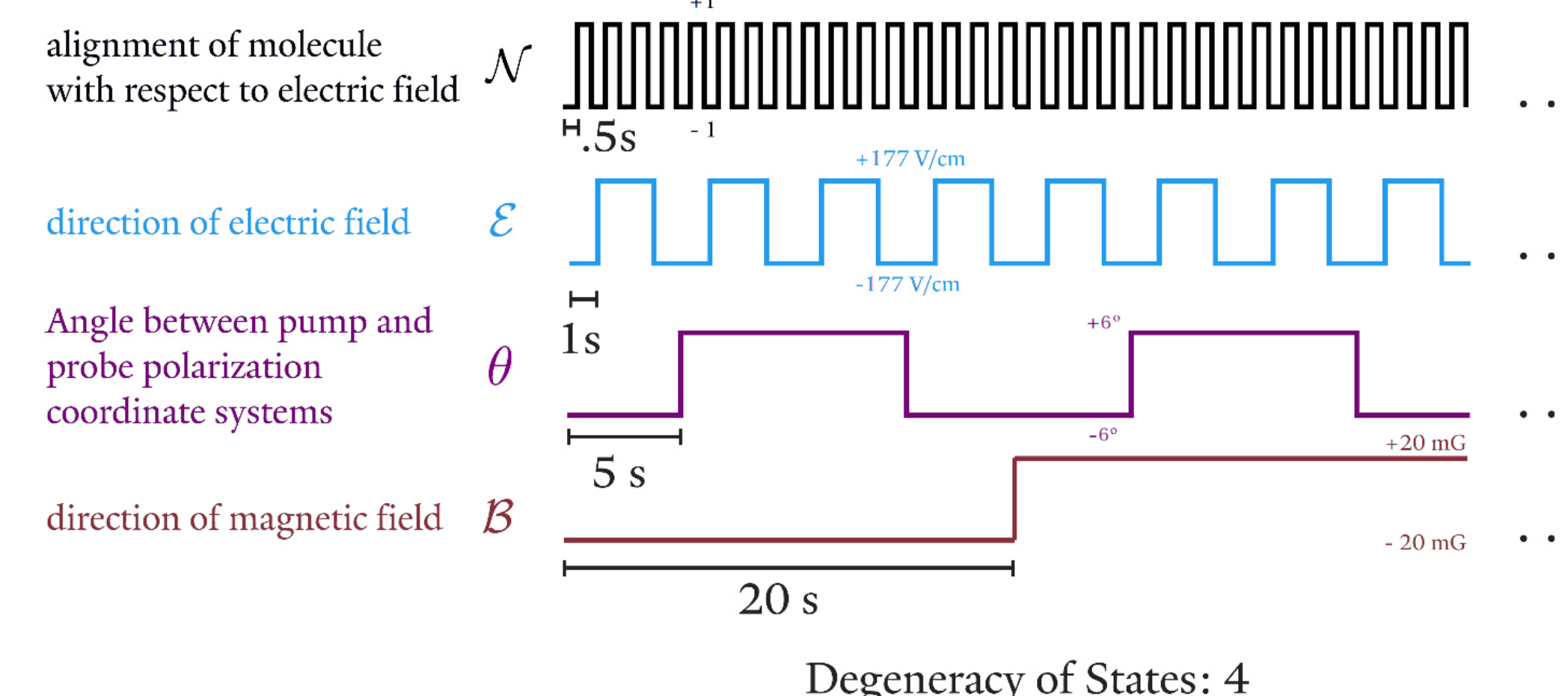
The spin precession is performed with different configurations of parameters that switch the sign of the different terms that contribute to the phase.

This enables us to extract the EDM contribution to the phase by performing "parity sums" of the different phases taken under different conditions, and also diagnose and suppress known systematic errors.

By performing the experiment with different values of \vec{N} , \vec{E} , \vec{B} we can extract the EDM channel ϕ^{NE} , the component of the phase which is odd under reversal of \vec{N} and \vec{E} .

This measurement scheme results in robust suppression of systematic effects: any imperfections in the system would have to be correlated with \vec{N} and \vec{E} to become a source of systematic error.

Parameter switch



$$\phi(\vec{N}, \vec{E}, \vec{B}) = \vec{N}\phi^N + \vec{E}\phi^E + \vec{B}\phi^B + \vec{N}\vec{E}\phi^{NE} + \vec{N}\vec{B}\phi^{NB} + \vec{E}\vec{B}\phi^{EB} + \vec{N}\vec{E}\vec{B}\phi^{NEB}$$

$$\vec{N}, \vec{E}, \vec{B} \in \{+1, -1\}$$

Systematic Search & Characterization

Other possible sources of systematic error are checked by intentionally exaggerating various imperfections in the system and measuring their effect on the EDM channel $\omega^{NE} = \frac{\phi^{NE}}{\tau}$, where τ is the precession time.

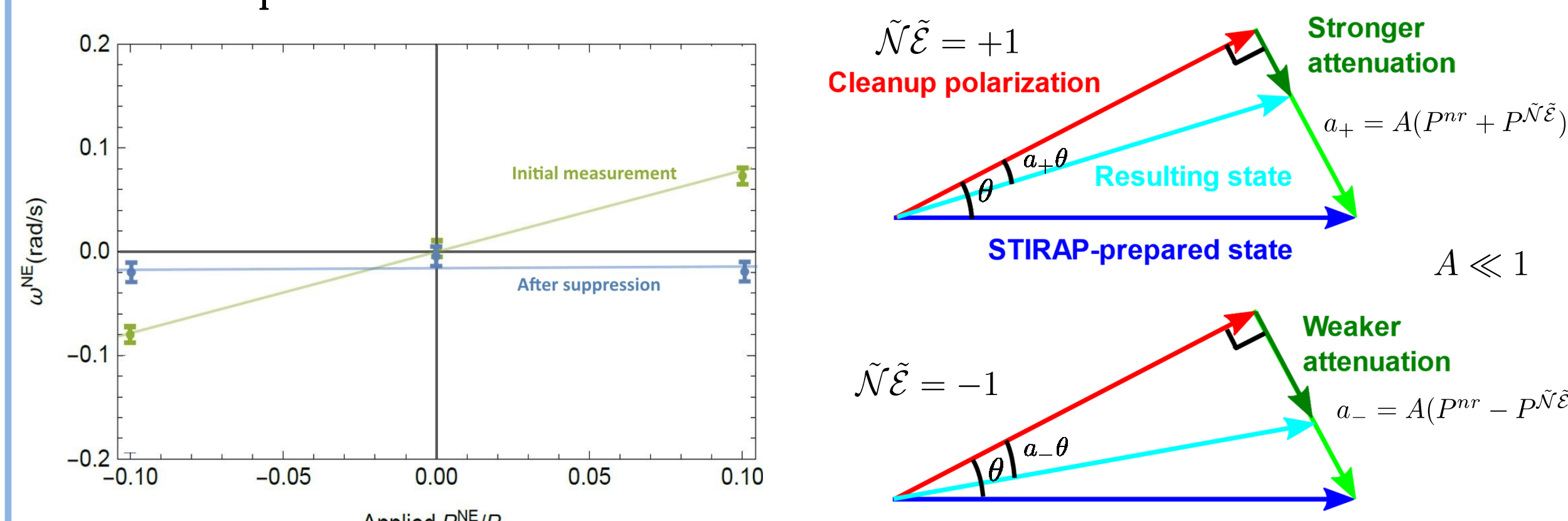
We have checked the main contributions to systematic error budget in ACME I and confirmed that they are all suppressed to below anticipated ACME II sensitivity levels. We are currently investigating secondary effects showing up in other (non-EDM) channels and continue varying system parameters, looking for possible shifts in the EDM channel.

Example: Correlation between prepared phase and power

We found a non-zero dependence of the EDM channel ω^{NE} vs applied cleanup laser power:

$$p^{app} = p^{nr}(1 + \vec{N}\vec{E}\frac{p^{NE}}{p^{nr}})$$

We observed that the slope depended on the global polarization angle of the lasers. If for some reason there turns out to be an intrinsic p^{NE} in the system, this could masquerade as an EDM.

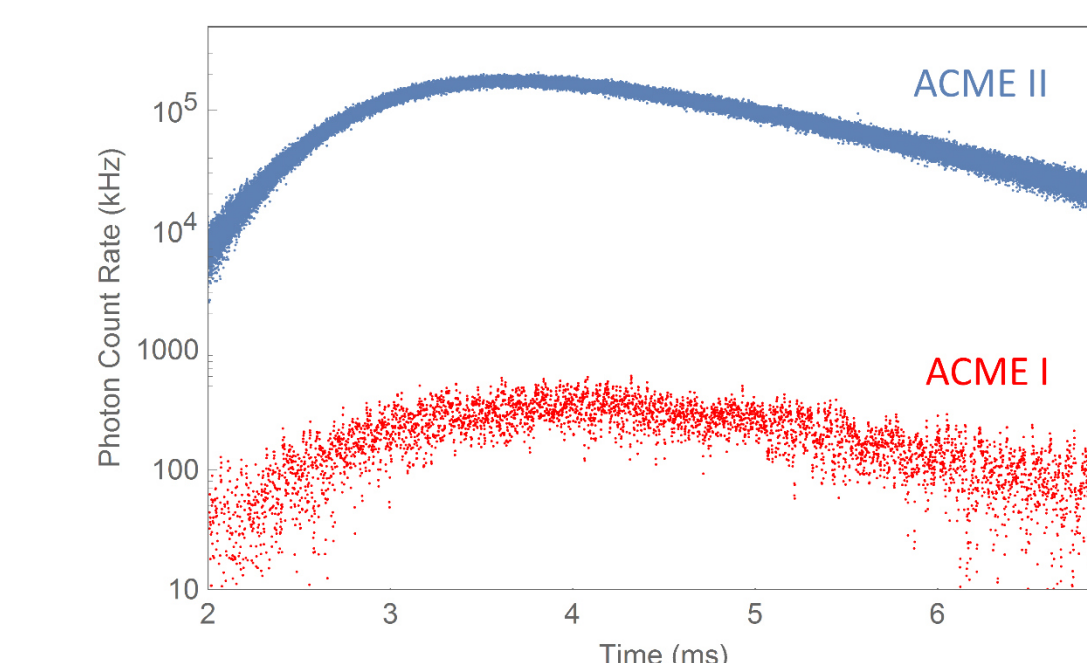


We discovered that this dependence arose from a misalignment in the angle between the initial spin state (prepared by STIRAP) and the cleanup laser polarization. The cleanup laser was not perfectly attenuating the component of the spin perpendicular to its polarization, resulting in a shift in ω^{NE} when p^{NE} is applied.

With sufficient cleanup power and tuning the global polarization angle we are able to suppress the possible systematic error arising from this to below our anticipated ACME II sensitivity.

Statistical Gains Versus ACME I

Demonstrated upgrades	Gain (molecule flux)
Geometric factors (shorter beamline, wider field plates)	$\sim 8 \times$
More efficient fluorescence collection	$\sim 2.5 \times$
STIRAP state preparation (upgrade from optical pumping)	$\sim 12 \times$
Higher quantum efficiency of PMTs at 512 nm detection wavelength	$\sim 2.5 \times$
Total demonstrated statistical improvement (actual)	$\sim 450 \times$



Comparison of ACME I and ACME II spin precession fluorescence data

Outlook

The ACME II measurement of the electron EDM is currently ongoing, measuring ThO spin precession with a daily statistical uncertainty of 10^{-29} e · cm.

We are currently checking for and investigating systematic effects, with the aim of a measurement near or better than 10^{-29} e · cm.

References

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More information: www.electroedm.info